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Process management for avionics – Atmospheric radiation effects – Part 5: Assessment of thermal neutron fluxes and single event effects in avionics systems

INTERNATIONAL ELECTROTECHNICAL COMMISSION

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PROCESS MANAGEMENT FOR AVIONICS – ATMOSPHERIC RADIATION EFFECTS –

Part 5: Assessment of thermal neutron fluxes and single event effects in avionics systems

FOREWORD

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International Standard IEC 62396-5 has been prepared by IEC technical committee 107: Process management for avionics.

This first edition cancels and replaces the first edition of IEC/TS 62396-5 published in 2008. This edition constitutes a technical revision.

This edition includes the following technical changes with respect to the previous technical specification:

- a) Change to title.
- b) Updated references and bibliography.
- c) Subclause 6.2 expanded to consider smaller geometry devices.

- d) Table 4 neutron cross-sections expanded to add more recent data and the ratio between thermal and high energy neutron cross-section amended to 2,42 from 2,77.
- e) Addition of reference section on thermal neutron high voltage burn out.
- f) New clause on determination of thermal neutron SEE rates for use in equipment assessments.
- g) Document aligned as an IEC standard.

The text of this international standard is based on the following documents:

FDIS	Report on voting
107/237/FDIS	107/242/RVD

Full information on the voting for the approval of this international standard can be found in the report on voting indicated in the above table.

This publication has been drafted in accordance with the ISO/IEC Directives, Part 2.

A list of all the parts in the IEC 62396 series, published under the general title *Process* management for avionics – Atmospheric radiation effects, can be found on the IEC website.

The committee has decided that the contents of this publication will remain unchanged until the stability date indicated on the IEC web site under "http://webstore.iec.ch" in the data related to the specific publication. At this date, the publication will be

- reconfirmed,
- withdrawn,
- replaced by a revised edition, or
- amended.

A bilingual version of this publication may be issued at a later date.

IMPORTANT – The 'colour inside' logo on the cover page of this publication indicates that it contains colours which are considered to be useful for the correct understanding of its contents. Users should therefore print this document using a colour printer.

PROCESS MANAGEMENT FOR AVIONICS – ATMOSPHERIC RADIATION EFFECTS –

Part 5: Assessment of thermal neutron fluxes and single event effects in avionics systems

1 Scope

The purpose of this part of IEC 62396 is to provide a more precise definition of the threat that thermal neutrons pose to avionics as a second mechanism for inducing single event upset (SEU) in microelectronics. There are two main points that will be addressed in this part of IEC 62396:

- a) a detailed evaluation of the existing literature on measurements of the thermal flux inside of airliners, and
- b) an enhanced compilation of the thermal neutron SEU cross-section in currently available SRAM devices (more than 20 different devices).

The net result of the reviews of these two different sets of data will be two ratios that are considered to be very important for leading to the ultimate objective of how large a threat is the SEU rate from thermal neutrons compared to the SEU threat from the high energy neutrons (E > 10 MeV). The threat from the high energy neutrons has been dealt with extensively in the literature and has been addressed by two standards (IEC 62396-1 in avionics and JESD89A [1]¹ in microelectronics on the ground). Neutrons with E > 1 MeV are considered for parts with geometries below 150 nm.

NOTE Reference is made to IEC 62396-1:2012, 5.3.2, for smaller geometry parts below 150 nm which provides the neutron flux for energies above 1 MeV.

2 Normative references

The following documents, in whole or in part, are normatively referenced in this document and are indispensable for its application. For dated references, only the edition cited applies. For undated references, the latest edition of the referenced document (including any amendments) applies.

IEC 62396-1:2012, Process management for avionics – Atmospheric radiation effects – Part 1: Accommodation of atmospheric radiation effects via single event effects within avionics electronic equipment

IEC 62396-4, Process management for avionics – Atmospheric radiation effects – Part 4: Design of high voltage aircraft electronics managing potential single event effects

¹ Numbers in square brackets refer to the Bibliography.